

## **Search Notes**



**Application/Control No.**

09/175,156

**Examiner**

Joseph T. Phan

**Applicant(s)/Patent under  
Reexamination**

PUTNAM ET AL.

## **Art Unit**

2614

**SEARCHED**

## **INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**